

March 2011

FDT86113LZ

N-Channel PowerTrench[®] MOSFET 100 V, 3.3 A, 100 m Ω

Features

- Max $r_{DS(on)}$ = 100 m Ω at V_{GS} = 10 V, I_D = 3.3 A
- Max $r_{DS(on)}$ = 145 m Ω at V_{GS} = 4.5 V, I_D = 2.7 A
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability in a widely used surface mount package
- HBM ESD protection level > 3 KV typical (Note 4)
- 100% UIL tested
- RoHS Compliant



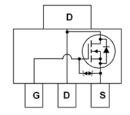
General Description

This N-Channel logic Level MOSFETs are produced using Fairchild Semiconductor's advanced Power Trench[®] process that has been special tailored to minimize the on-state resistance and yet maintain superior switching performance. G-S zener has been added to enhance ESD voltage level.

Application

■ DC - DC Switch





MOSFET Maximum Ratings T_C = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			100	V	
V _{GS}	Gate to Source Voltage			±20	V	
1	Drain Current -Continuous			3.3	^	
ID	-Pulsed			12	A	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	9	mJ	
D	Power Dissipation T	_A = 25 °C	(Note 1a)	2.2	W	
P_{D}	Power Dissipation T	_A = 25 °C	(Note 1b)	1.0	VV	
T _J , T _{STG}	Operating and Storage Junction Temperature Rang	je		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	12	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	55	C/VV

Package Marking and Ordering Information

Ĭ	Device Marking	Device	Package	Reel Size	Tape Width	Quantity
Ī	86113LZ	FDT86113LZ	SOT-223	13 "	12 mm	2500 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		71		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μΑ

On Characteristics (Note 2)

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0	1.7	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-5		mV/°C
	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 3.3 \text{ A}$		75	100	- mΩ
r		$V_{GS} = 4.5 \text{ V}, I_D = 2.7 \text{ A}$		95	145	
r _{DS(on)} Static Drain to \$	Static Drain to Source On Nesistance	$V_{GS} = 10 \text{ V}, I_D = 3.3 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$		140	189	11152
9 _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_D = 3.3 \text{ A}$		8		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V - 50 V V - 0 V	234	315	pF
C _{oss}	Output Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz	46	65	pF
C _{rss}	Reverse Transfer Capacitance	1 1411 12	3.1	5	pF

Switching Characteristics

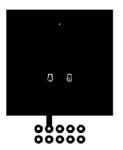
t _{d(on)}	Turn-On Delay Time		3.8	10	ns
t _r	Rise Time	V _{DD} = 50 V, I _D = 3.3 A,	1.3	10	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	10	20	ns
t _f	Fall Time		1.5	10	ns
Q_q	Total Gate Charge	V _{GS} = 0 V to 10 V	4.1	6.8	nC
Q_q	Total Gate Charge	$V_{GS} = 0 \text{ V to 5 V}$ $V_{DD} = 50 \text{ V},$	2.3	3.9	nC
Q_{gs}	Gate to Source Gate Charge	I _D = 3.3 A	0.68		nC
Q_{qd}	Gate to Drain "Miller" Charge		0.85		nC

Drain-Source Diode Characteristics

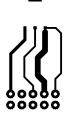
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 3.3 \text{ A}$ (Note 2)	0.86	1.3	V
	Source to Drain Diode 1 of ward voltage	$V_{GS} = 0 V, I_S = 1 A$ (Note 2)	0.77	1.2	
t _{rr}	Reverse Recovery Time	I _E = 3.3 A, di/dt = 100 A/μs	31	49	ns
Q _{rr}	Reverse Recovery Charge	i _F = 3.3 A, di/dt = 100 A/μs	21	34	nC

Notes:

^{1.} R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0JA} is determined by the user's board design.



a) 55 °C/W when mounted on a 1 in² pad of 2 oz copper



b) 118 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. Starting $\rm T_J$ = 25°C, L = 0.3 mH, $\rm I_{AS}$ = 8 A, $\rm V_{DD}$ = 90 V, $\rm V_{GS}$ = 10 V.
- 4. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

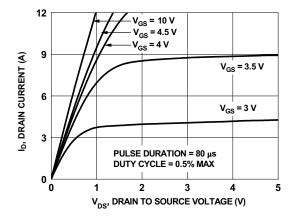


Figure 1. On-Region Characteristics

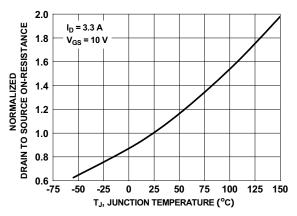


Figure 3. Normalized On-Resistance vs Junction Temperature

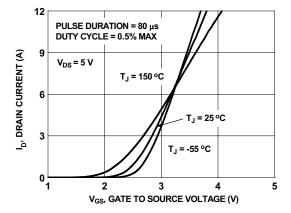


Figure 5. Transfer Characteristics

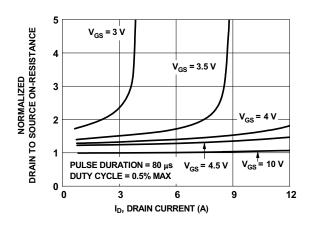


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

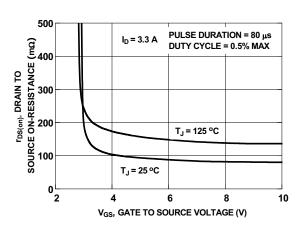


Figure 4. On-Resistance vs Gate to Source Voltage

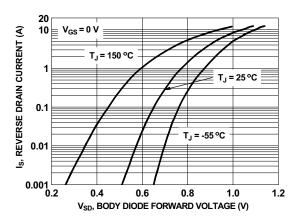


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

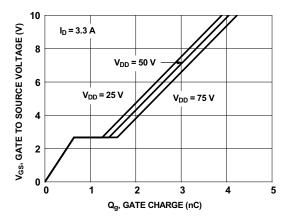
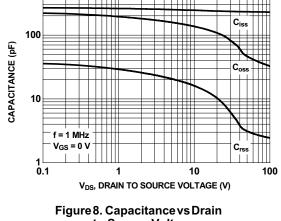


Figure 7. Gate Charge Characteristics



400

to Source Voltage

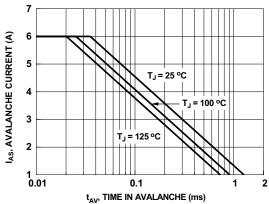


Figure 9. Unclamped Inductive **Switching Capability**

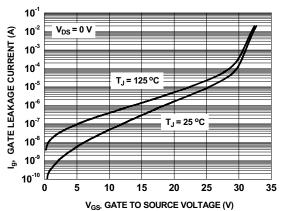


Figure 10. Gate Leakage Current vs Gate to Source Voltage

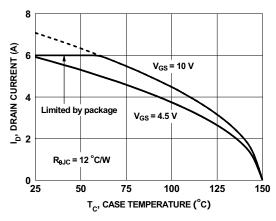


Figure 11. Maximum Continuous Drain **Current vs Case Temperature**

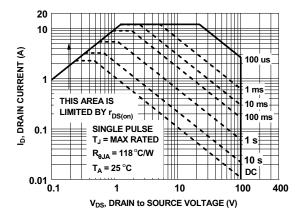


Figure 12. Forward Bias Safe **Operating Area**



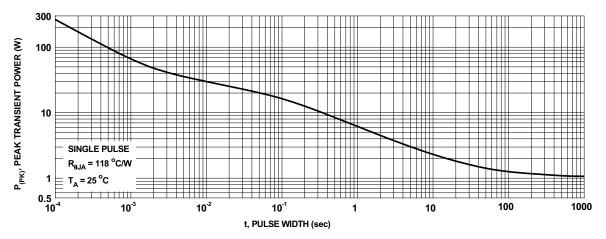


Figure 13. Single Pulse Maximum Power Dissipation

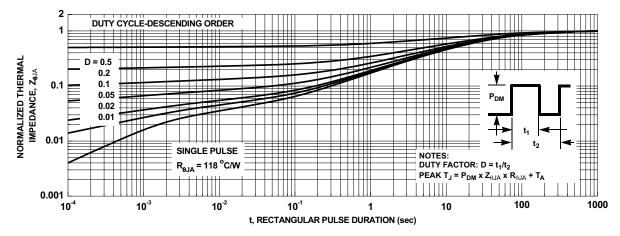
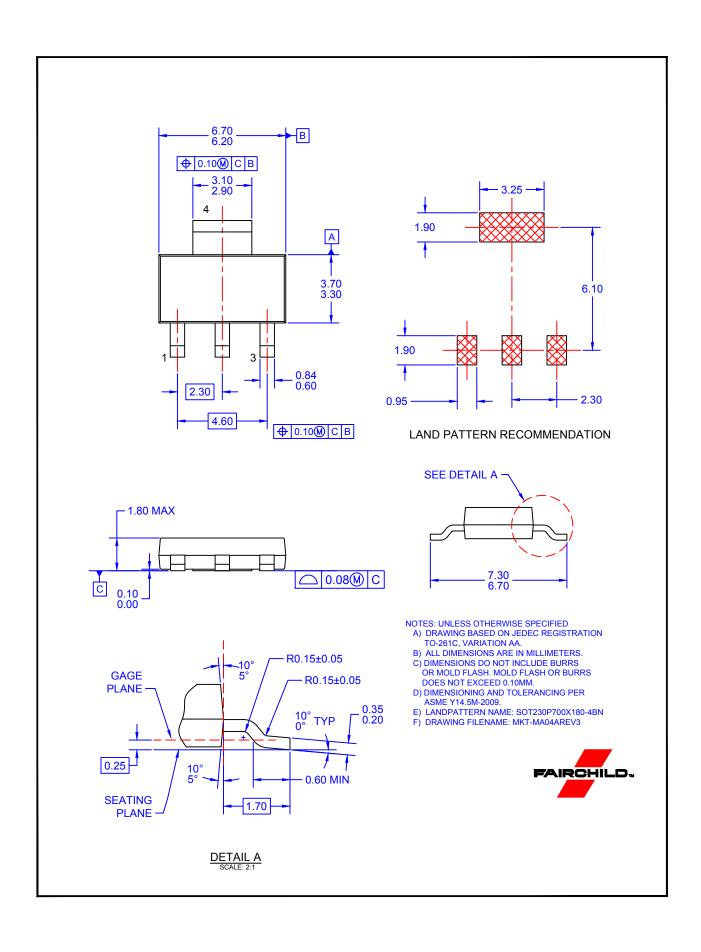


Figure 14. Junction-to-Ambient Transient Thermal Response Curve







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